

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/573,539	FRENZEL, HENRYK	
Examiner		Art Unit		Page 1 of 1
Erin D. Chiem		2883		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0050717	12-2001	Yamada et al.	348/340
*	B	US-2003/0193609	10-2003	Kothmeier, Georg-Emil	348/340
*	C	US-2003/0025825	02-2003	Nakajoh, Yasuo	348/374
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	EP 1081944 A2	03-2001	European Patent	HOSHINO et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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